

IESI REPORT



Deutsche Akkreditierungsstelle

D-PL-12076-01-00

Test report no.: 1-1018/15-01-02

Testing laboratory

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Accredited Testing Laboratory: The testing laboratory (area of testing) is accredited according to DIN EN ISO/IEC 17025 (2005) by the Deutsche Akkreditierungsstelle GmbH (DAkkS) The accreditation is valid for the scope of testing procedures as stated in the accreditation certificate with the registration number: D-PL-12076-01-00 Applicant

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Manufacturer

ifm electronic gmbh Friedrichsstraße 1 45128 Essen / GERMANY

Test standard/s

47 CFR Part 15 Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices

RSS - 210 Issue 8Spectrum Management and Telecommunications Radio Standards Specification -
Licence-exempt Radio Apparatus (All Frequency Bands): Category I Equipment

For further applied test standards please refer to section 3 of this test report.

	Test Item	
Kind of test item:	13,56 MHz RFID Reader	
Model name:	ANT515	
FCC ID:	UN6-DTRHFKQ	
IC:	6799A	O B ANTSIS
Frequency:	13.56 MHz	Production and the second seco
Technology tested:	RFID	
Antenna:	Integrated antenna	
Power supply:	19.2 V to 28.8 V DC by ext. power supply	The second s
Temperature range:	-20°C to +60°C	1 Martin Carlos

This test report is electronically signed and valid without handwriting signature. For verification of the electronic signatures, the public keys can be requested at the testing laboratory.

Test report authorized:

Marco Bertolino Lab Manager Radio Communications & EMC

Test performed:

Christoph Schneider Testing Manager Radio Communications & EMC



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2 General information

2.1 Notes and disclaimer

The test results of this test report relate exclusively to the test item specified in this test report. CETECOM ICT Services GmbH does not assume responsibility for any conclusions and generalizations drawn from the test results with regard to other specimens or samples of the type of the equipment represented by the test item.

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2.2 Application details

Date of receipt of order:	2016-01-26
Date of receipt of test item:	2016-02-01
Start of test:	2016-02-09
End of test:	2016-02-16
Person(s) present during the test:	-/-

3 Test standard/s and references

Test standard	Date	Description
47 CFR Part 15		Title 47 of the Code of Federal Regulations; Chapter I; Part 15 - Radio frequency devices
RSS - 210 Issue 8	December 2010	Spectrum Management and Telecommunications Radio Standards Specification - Licence-exempt Radio Apparatus (All Frequency Bands): Category I Equipment

Guidance	Version	Description
ANSI C63.4-2014	-/-	American national standard for methods of measurement of radio- noise emissions from low-voltage electrical and electronic equipment in the range of 9 kHz to 40 GHz
ANSI C63.10-2013	-/-	American national standard of procedures for compliance testing of unlicensed wireless devices



4 Test environment

Temperature : Tnom T _{max} T _{min}		T _{max}	 +22 °C during room temperature tests +60 °C during high temperature tests -20 °C during low temperature tests 		
Relative humidity content : 55 %		55 %			
Barometric pressure :			not relevant for this kind of testing		
Power supply : V _{nom} V _{max} V _{min}		V_{max}	24.0 V DC by ext. power supply 28.8 V 19.2 V		

5 Test item

5.1 General description

Kind of test item :	13,56 MHz RFID Reader
Type identification :	ANT515
HMN :	n.a.
PMN :	ANT515
HVIN :	ANT515
FVIN :	ANT515
S/N serial number :	AB
HW hardware status :	n.a.
SW software status :	n.a.
Frequency band :	13.56 MHz
Type of radio transmission : Use of frequency spectrum :	single carrier
Type of modulation :	ASK
Number of channels :	1
Antenna :	Integrated antenna
Power supply :	19.2 V to 28.8 V DC by ext. power supply
Temperature range :	-20°C to +60°C

5.2 Additional information

The content of the following annexes is defined in the QA. It may be that not all of the listed annexes are necessary for this report, thus some values in between may be missing.

Test setup- and EUT-photos are included in test report:

1-1018/15-01-01_AnnexA 1-1018/15-01-01_AnnexB 1-1018/15-01-01_AnnexD

6 Test laboratories sub-contracted

None



7 Description of the test setup

Typically, the calibrations of the test apparatus are commissioned to and performed by an accredited calibration laboratory. The calibration intervals are determined in accordance with the DIN EN ISO/IEC 17025. In addition to the external calibrations, the laboratory executes comparison measurements with other calibrated test systems or effective verifications. Weekly chamber inspections and range calibrations are performed. Where possible, RF generating and signaling equipment as well as measuring receivers and analyzers are connected to an external high-precision 10 MHz reference (GPS-based or rubidium frequency standard).

In order to simplify the identification of the equipment used at some special tests, some items of test equipment and ancillaries can be provided with an identifier or number in the equipment list below (Lab/Item).

Agenda: Kind of Calibration

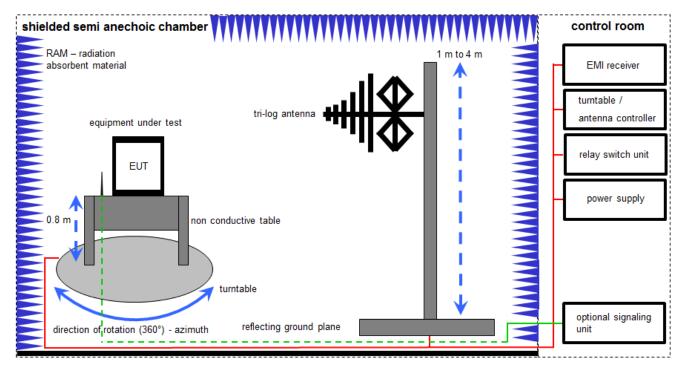
- k calibration / calibrated
- ne not required (k, ev, izw, zw not required)
- ev periodic self verification
- Ve long-term stability recognized
- vlkl! Attention: extended calibration interval
- NK! Attention: not calibrated

- EK limited calibration
- zw cyclical maintenance (external cyclical maintenance)
- izw internal cyclical maintenance
- g blocked for accredited testing
- *) next calibration ordered / currently in progress



7.1 Shielded semi anechoic chamber

The radiated measurements are performed in vertical and horizontal plane in the frequency range from 9 kHz to 1 GHz in semi-anechoic chambers. The EUT is positioned on a non-conductive support with a height of 0.80 m above a conductive ground plane that covers the whole chamber. The receiving antennas are confirmed with specifications ANSI C63. These antennas can be moved over the height range between 1.0 m and 4.0 m in order to search for maximum field strength emitted from EUT. The measurement distances between EUT and receiving antennas are indicated in the test setups for the various frequency ranges. For each measurement, the EUT is rotated in all three axes until the maximum field strength is received. The wanted and unwanted emissions are received by spectrum analyzers where the detector modes and resolution bandwidths over various frequency ranges are set according to requirement ANSI C63.



Measurement distance: tri-log antenna 10 meter

FS = UR + CL + AF

(FS-field strength; UR-voltage at the receiver; CL-loss of the cable; AF-antenna factor)

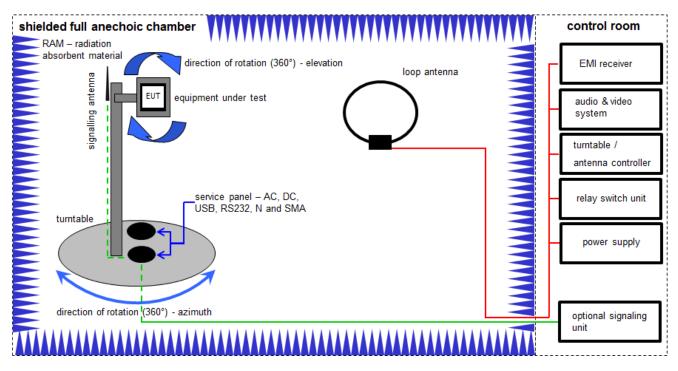
Example calculation:

 $FS [dB\mu V/m] = 12.35 [dB\mu V/m] + 1.90 [dB] + 16.80 [dB/m] = 31.05 [dB\mu V/m] (35.69 \mu V/m)$

No.	Lab / Item	Equipment	Туре	Manufact.	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	Α	Switch-Unit	3488A	HP	2719A14505	30000368	ev	-/-	-/-
2	A	DC power supply, 60Vdc, 50A, 1200 W	6032A	HP	2920A04466	300000580	ne	-/-	-/-
3	Α	EMI Test Receiver	ESCI 3	R&S	100083	300003312	k	26.01.2016	26.01.2017
4	Α	Antenna Tower	Model 2175	ETS-Lindgren	64762	300003745	izw	-/-	-/-
5	А	Positioning Controller	Model 2090	ETS-Lindgren	64672	300003746	izw	-/-	-/-
6	A	Turntable Interface- Box	Model 105637	ETS-Lindgren	44583	300003747	izw	-/-	-/-
7	А	TRILOG Broadband Test-Antenna 30 MHz - 3 GHz	VULB9163	Schwarzbeck	295	300003787	k	22.04.2014	22.04.2016



7.2 Shielded fully anechoic chamber



Measurement distance: loop antenna 3 meter / 1 meter

FS = UR + CA + AF (FS-field strength; UR-voltage at the receiver; CA-loss of the signal path; AF-antenna factor)

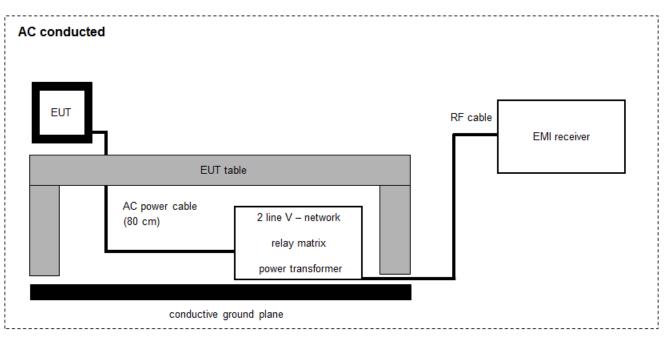
Example calculation:

 $FS [dB\mu V/m] = 40.0 [dB\mu V/m] + (-35.8) [dB] + 32.9 [dB/m] = 37.1 [dB\mu V/m] (71.61 \mu V/m)$

No.	Lab / Item	Equipment	Туре	Manufact.	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	А	Anechoic chamber	FAC 3/5m	MWB / TDK	87400/02	300000996	ev	-/-	-/-
2	A	Active Loop Antenna 10 kHz to 30 MHz	6502	EMCO/2	8905-2342	300000256	k	24.06.2015	24.06.2017
3	А	4U RF Switch Platform	L4491A	Agilent Technologies	MY50000037	300004509	ne	-/-	-/-
4	А	EMI Test Receiver 9kHz-26,5GHz	ESR26	R&S	101376	300005063	k	04.09.2015	04.09.2016
5	А	DC power supply, 60Vdc, 50A, 1200 W	6032A	HP	2920A04590	300001041	Ve	20.01.2015	20.01.2018



7.3 AC conducted



FS = UR + CF + VC

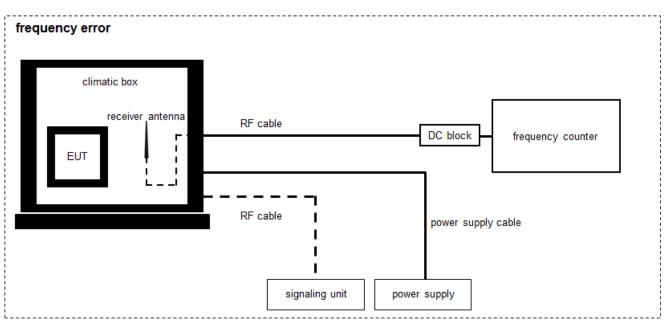
(FS-field strength; UR-voltage at the receiver; CR-loss of the cable and filter; VC-correction factor of the ISN)

 $\frac{Example \ calculation:}{FS \ [dB\muV/m] = 37.62 \ [dB\muV/m] + 9.90 \ [dB] + 0.23 \ [dB] = 47.75 \ [dB\muV/m] \ (244.06 \ \muV/m)}$

No.	Lab / Item	Equipment	Туре	Manufact.	Serial No.	INV. No Cetecom		Last Calibration	Next Calibration
14	n. a.	Two-line V-Network (LISN) 9 kHz to 30 MHz	ESH3-Z5	R&S	892475/017	300002209	k	17.06.2014	17.06.2016
15	68	MXE EMI-Receiver	N9038A	Agilent Technologies	MY51210197	300004405	k	06.03.2015	06.03.2016
16	68	Analyzer-Reference- System (Harmonics and Flicker)	ARS 16/1	SPS	A3509 07/0 0205	300003314	Ve	11.02.2014	11.02.2016



7.4 Frequency error



No.	Lab / Item	Equipment	Туре	Manufact.	Serial No.	INV. No Cetecom	Kind of Calibration	Last Calibration	Next Calibration
1	А	DC power supply, 60Vdc, 50A, 1200 W	6032A	HP	2920A04590	300001041	Ve	20.01.2015	20.01.2018
2	А	Temperature Test Chamber	VT 4002	Heraeus Voetsch	521/83761	300002326	ev	03.09.2015	03.09.2017
3	A	Signal Analyzer 20Hz-26,5GHz-150 to + 30 DBM	FSiQ26	R&S	835111/0004	300002678	Ve	22.01.2015	22.01.2017
4	A	EMI Test Receiver 9 kHz - 3 GHz incl. Preselector	ESPI3	R&S	101713	300004059	k	26.01.2016	25.01.2017
5	A	Loop Antenna	RPC3519	ZEG TS Steinfurt	101713	400001208	ev	-/-	-/-
6	A	RF Cable BNC	RG58	Huber & Suhner	101713	400001209	ev		



8 Sequence of testing

8.1 Sequence of testing radiated spurious 9 kHz to 30 MHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a 2-axis positioner with 1.5 m height is used.
- If the EUT is a floor standing device, it is placed directly on the turn table.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 3 m (see ANSI C 63.4) see test details.
- EUT is set into operation.

Premeasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna height is 1.5 m.
- At each turntable position the analyzer sweeps with positive-peak detector to find the maximum of all emissions.

Final measurement

- Identified emissions during the premeasurement are maximized by the software by rotating the turntable from 0° to 360°. In case of the 2-axis positioner is used the elevation axis is also rotated from 0° to 360°.
- The final measurement is done in the position (turntable and elevation) causing the highest emissions with quasi-peak (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, turntable position, correction factor, margin to the limit and limit will be recorded. A plot with the graph of the premeasurement and the limit is stored.



8.2 Sequence of testing radiated spurious 30 MHz to 1 GHz

Setup

- The equipment is set up to simulate normal operation mode as described in the user manual or defined by the manufacturer.
- If the EUT is a tabletop system, a table with 0.8 m height is used, which is placed on the ground plane.
- If the EUT is a floor standing device, it is placed on the ground plane with insulation between both.
- Auxiliary equipment and cables are positioned to simulate normal operation conditions as described in ANSI C 63.4.
- The AC power port of the EUT (if available) is connected to a power outlet below the turntable.
- Measurement distance is 10 m or 3 m (see ANSI C 63.4) see test details.
- EUT is set into operation.

Premeasurement

- The turntable rotates from 0° to 315° using 45° steps.
- The antenna is polarized vertical and horizontal.
- The antenna height changes from 1 m to 3 m.
- At each turntable position, antenna polarization and height the analyzer sweeps three times in peak to find the maximum of all emissions.

Final measurement

- The final measurement is performed for at least six highest peaks according to the requirements of the ANSI C63.4.
- Based on antenna and turntable positions at which the peak values are measured the software maximize the peaks by changing turntable position ± 45° and antenna height between 1 and 4 m.
- The final measurement is done with quasi-peak detector (as described in ANSI C 63.4).
- Final levels, frequency, measuring time, bandwidth, antenna height, antenna polarization, turntable angle, correction factor, margin to the limit and limit are recorded. A plot with the graph of the premeasurement with marked maximum final results and the limit is stored.

9 Measurement uncertainty

Measurement uncertainty						
Test case	Uncertainty					
Spectrum bandwidth	± 21.5 kHz absolute; ± 15.0 kHz relative					
Maximum output power	± 1 dB					
Spurious emissions radiated below 30 MHz	± 3 dB					
Spurious emissions radiated 30 MHz to 1 GHz	± 3 dB					
Frequency error	± 10 Hz					



10 Summary of measurement results

\boxtimes	No deviations from the technical specifications were ascertained
	There were deviations from the technical specifications ascertained
	This test report is only a partial test report. The content and verdict of the performed test cases are listed below.

TC Identifier	Description	Verdict	Date	Remark
RF-Testing	CFR Part 15 RSS 210 Issue 8 RSS Gen Issue 4	See table!	2016-03-30	-/-

Test specification clause	Test case	Temperature conditions	Power source conditions	С	NC	NA	NP	Remark
RSS Gen Issue 4	Occupied bandwidth	Nominal	Nominal	\boxtimes				-/-
§ 15.225 (a)	Field strength of the fundamental	Nominal	Nominal	\boxtimes				-/-
§ 15.209 & § 15.225 (b-d)	Field strength of the harmonics and spurious	Nominal	Nominal	\boxtimes				-/-
§ 15.109	Receiver spurious emissions and cabinet radiations	Nominal	Nominal					Collocated receiver
§15.107 §15.207	Conducted limits	Nominal	Nominal	\boxtimes				-/-
§ 15.225 (a)	Frequency tolerance	Normal & extreme conditions	Normal & extreme conditions	\boxtimes				-/-

<u>Note:</u> C = Compliant; NC = Not compliant; NA = Not applicable; NP = Not performed

11 Additional comments

Reference documents: None

Special test descriptions: None

Configuration descriptions: None



12 Measurement results

12.1 Occupied bandwidth

Measurement:

The emission bandwidth (x dB) is defined as the frequency range between two points, one above and one below the carrier frequency, at which the spectral density of the emission is attenuated x dB below the maximum in-band spectral density of the modulated signal.

Measurement parameters				
Detector:	Peak			
Resolution bandwidth:	1 % - 5 % of the occupied bandwidth			
Video bandwidth:	≥ 3x RBW			
Trace mode:	Max hold			
Analyser function:	99 % power function			
Used equipment:	See chapter 7.4 A			
Measurement uncertainty:	See chapter 9			

Limit:

IC		
for RSP-100 test report c	oversheet only	

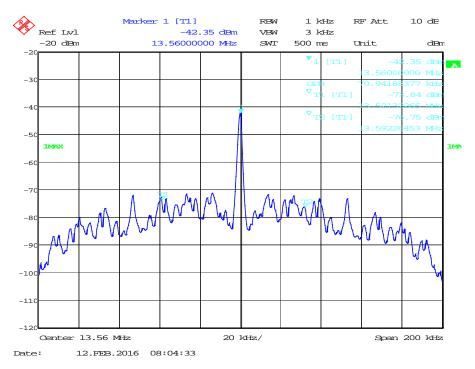
Result:

99% emission bandwidth
70.94 kHz



Plot:







12.2 Field strength of the fundamental

Measurement:

The maximum detected field strength for the carrier signal.

Measurement parameters				
Detector:	Quasi peak / peak (worst case)			
Resolution bandwidth:	120 kHz			
Video bandwidth:	≥ 3x RBW			
Trace mode:	Max hold			
Used equipment:	See chapter 7.2 A			
Measurement uncertainty:	See chapter 9			

Limit:

FCC & IC				
Frequency	Field strength	Measurement distance		
(MHz)	(µV/m)	(m)		
13.553 to 13.567	15.848 (84 dBµV/m)	30		

Recalculation:

According to ANSI C63.10					
Frequency	Formula	Correction value			
13.56 MHz	$\begin{split} FS_{limit} &= FS_{max} - 40 \log \left(\frac{d_{\textit{limit}}}{d_{\textit{measure}}} \right) - 20 log(\frac{d_{\textit{limit}}}{d_{\textit{measure}}}) \\ FS_{\textit{limit}} & \text{is the calculation of field strength at the limit distance,} \\ expressed in dB_{\mu}V/m \\ FS_{max} & \text{is the measured field strength, expressed in dB_{\mu}V/m} \\ d_{\textit{measure}} & \text{is the MA2rr distance} \\ d_{\textit{measure}} & \text{is the distance of the measurement point from EUT} \\ d_{\textit{limit}} & \text{is the distance} \\ \end{array}$	-21.39			

According to ANSI C63.10

Result:

Field strength of the fundamental				
Frequency	13.56 MHz			
Distance	@ 3 m @ 30 m			
Measured / calculated value	51.50 dBµV/m	30.11 dBµV/m		



12.3 Field strength of the harmonics and spurious

Measurement:

The maximum detected field strength for the harmonics and spurious.

Measurement parameters				
Detector:	Quasi peak / average or			
Detector.	peak (worst case – pre-scan)			
	F < 150 kHz: 200 Hz			
Resolution bandwidth:	150 kHz < F < 30 MHz: 9 kHz			
	30 MHz < F < 1 GHz: 120 kHz			
	F < 150 kHz: 1 kHz			
Video bandwidth:	150 kHz < F < 30 MHz: 100 kHz			
	30 MHz < F < 1 GHz: 300 kHz			
Trace mode:	Max hold			
Used equipment:	See chapter 7.1 A / 7.2 A			
Measurement uncertainty:	See chapter 9			

Limit:

FCC & IC					
Frequency	Field strength	Measurement distance			
(MHz)	(dBµV/m)	(m)			
0.009 - 0.490	2400/F(kHz)	300			
0.490 - 1.705	24000/F(kHz)	30			
1.705 – 30	30 (29.5 dBµV/m)	30			
30 - 88	100 (40 dBµV/m)	3			
88 – 216	150 (43.5 dBµV/m)	3			
216 – 960	200 (46 dBµV/m)	3			

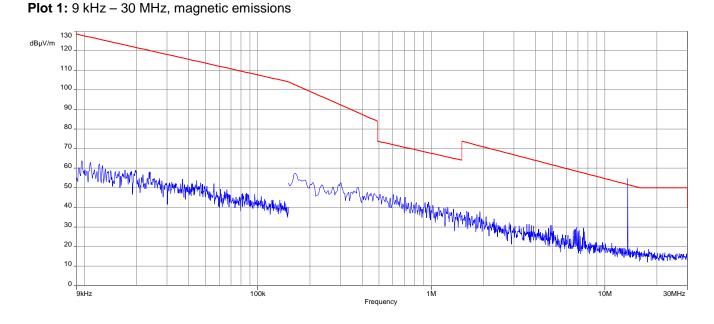
Note: For a reduced measurement distance, please take a look at the limit line and the ANSI C63.10-2013 sub clause 6.4 radiated emissions from unlicensed wireless devices below 30 MHz.

Result:

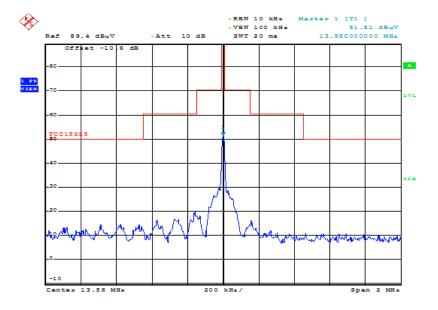
	Detected	emissions	
Frequency (MHz)DetectorResolution bandwidth (kHz)Detected value			Detected value
	No emissions closer	than 10 dB to the limit.	



Plots:



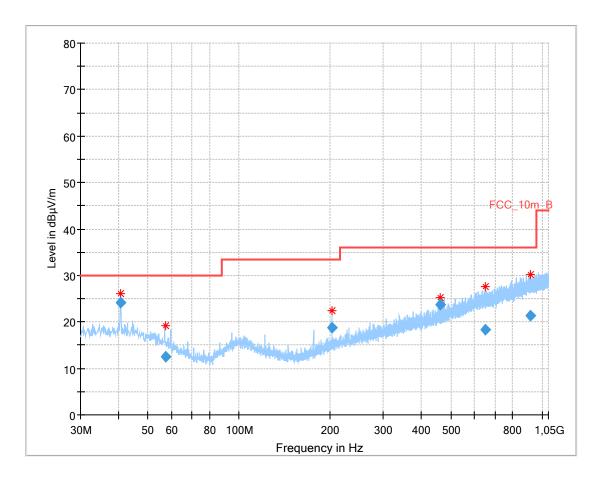
Plot 2: Spectrum mask (the limits are recalculated according to the ANSI C63.10-2013 sub clause 6.4)



Date: 12.FEB.2016 10:24:03







Final_Result

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Meas. Time (ms)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
40.663500	24.22	30.00	5.78	1000.0	120.000	98.0	V	174.0	14.0
57.138450	12.56	30.00	17.44	1000.0	120.000	101.0	V	5.0	11.3
203.426700	18.76	33.50	14.74	1000.0	120.000	98.0	V	198.0	11.8
461.024550	23.77	36.00	12.23	1000.0	120.000	170.0	Н	130.0	17.9
649.483500	18.28	36.00	17.72	1000.0	120.000	170.0	V	84.0	21.1
918.923550	21.28	36.00	14.72	1000.0	120.000	170.0	Н	103.0	24.2



12.4 Conducted limits

Measurement:

Measurement of the conducted spurious emissions for an intentional radiator that is designed to be connected to the public utility (AC) power line.

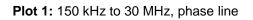
Measurement parameters		
Detector:	Quasi peak / average or	
Delector.	peak (worst case – pre-scan)	
Resolution bandwidth:	F < 150 kHz: 200 Hz	
Resolution bandwidth.	F > 150 kHz: 9 kHz	
Video bandwidth:	F < 150 kHz: 1 kHz	
	F > 150 kHz: 100 kHz	
Trace mode:	Max hold	
Used equipment:	See chapter 7.3 A	
Measurement uncertainty:	See chapter 9	

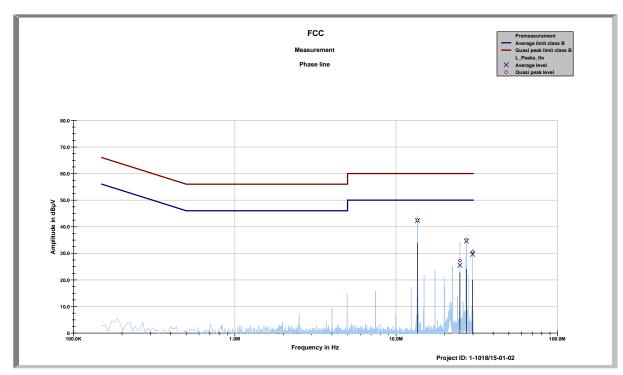
Limit:

	FCC & IC	
Frequency	Quasi-peak	Average
(MHz)	(dBµV/m)	(dBµV/m)
0.15 – 0.5	66 to 56*	56 to 46*
0.5 – 5	56	46
5 - 30.0	60	50



Plots:

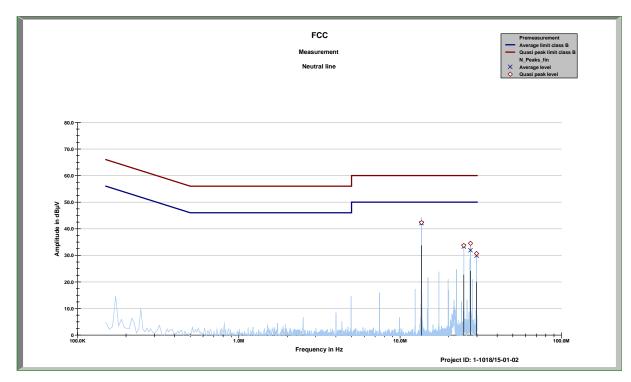




Frequency	Quasi peak level	Margin quasi peak	Average level	Margin average
MHz	dBμV	dBμV	dBμV	dBµV
13.562	42.47	17.53	42.29	7.71
24.838	27.29	32.71	25.54	24.46
27.317	35.04	24.96	34.60	15.40
29.8023	30.63	29.37	29.64	20.36



Plot 2: 150 kHz to 30 MHz, neutral line



Frequency	Quasi peak level	Margin quasi peak	Average level	Margin average
MHz	dBμV	dBµV	dBμV	dBµV
13.562	42.31	17.69	42.10	7.90
24.818	33.73	26.27	33.32	16.68
27.307	34.53	25.47	31.92	18.08
29.7879	30.69	29.31	29.88	20.12



12.5 Frequency error

Measurement:

The maximum detected field strength for the spurious.

Measurement parameters		
Detector:	Peak detector	
Resolution bandwidth:	10 Hz / 100 Hz	
Video bandwidth:	> RBW	
Trace mode:	Max hold	
Used equipment:	See chapter 7.4 A	
Measurement uncertainty:	See chapter 9	

Limit:

FCC The frequency tolerance of the carrier signal shall be maintained within +/- 0.01% of the operating frequency over a temperature variation of -20 degrees to +60 degrees C at normal supply voltage, and for a variation in the primary supply voltage from 85% to 115% of the rated supply voltage at a temperature of 20 degrees C. (±1.356 kHz)



Result: Temperature variation

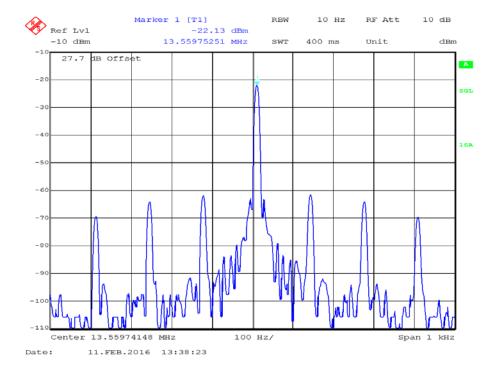
	Frequency tolerance	
Measured frequency (MHz)	Conditions	Result
13.559640	-20 °C & 100% voltage	compliant
13.559495	-10 °C & 100% voltage	compliant
13.559454	0 °C & 100% voltage	compliant
13.559737	+10 °C & 100% voltage	compliant
13.559708	+20 °C & 100% voltage	compliant
13.559718	+30 °C & 100% voltage	compliant
13.559704	+40 °C & 100% voltage	compliant
13.559627	+50 °C & 100% voltage	compliant
13.559753	+60 °C & 100% voltage	compliant

Result: Voltage variation

	Frequency tolerance	
Measured frequency (MHz)	Temperature	Result
13.559711	+20 °C & 85% voltage	compliant
13.559708	+20 °C & 100% voltage	compliant
13.559721	+20 °C & 115% voltage	compliant

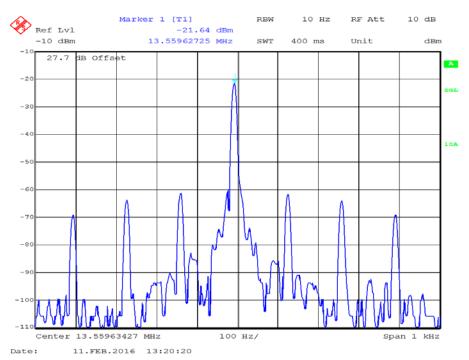


Plots:



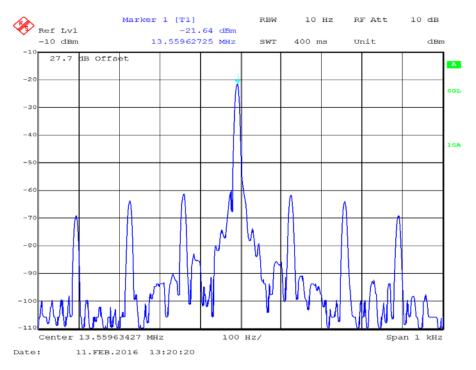
Plot 1: 100% voltage; 60°C

Plot 2: 100% voltage; 50°C

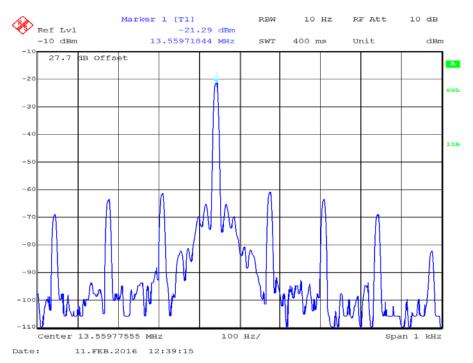




Plot 3: 100% voltage; 40°C

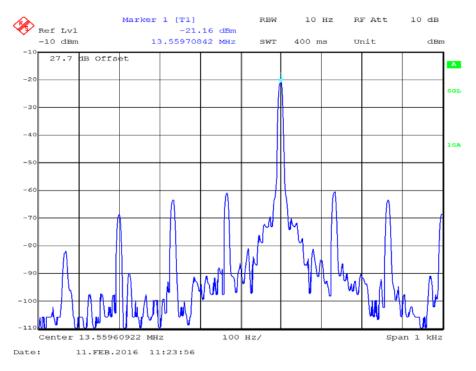


Plot 4: 100% voltage; 30°C

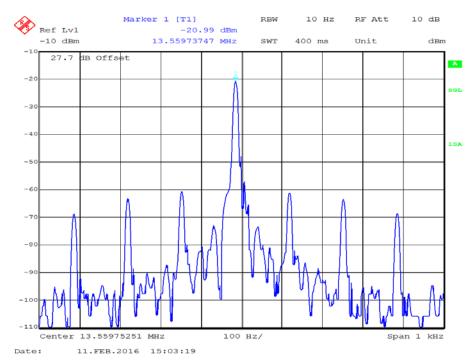




Plot 5: 100% voltage; 20°C

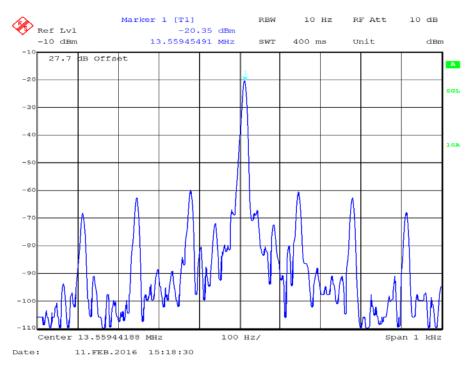


Plot 6: 100% voltage; 10°C

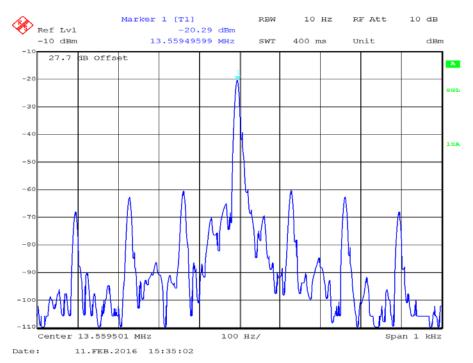




Plot 7: 100% voltage; 0°C

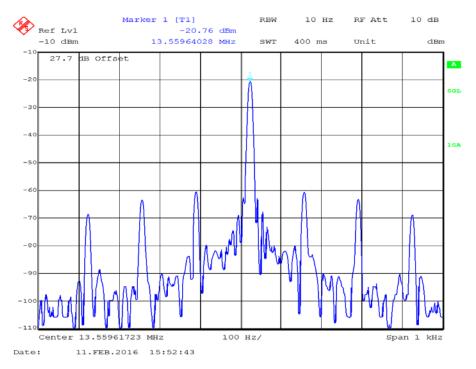


Plot 8: 100% voltage; -10°C

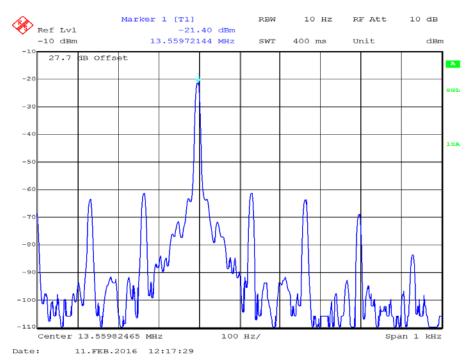




Plot 9: 100% voltage; -20°C

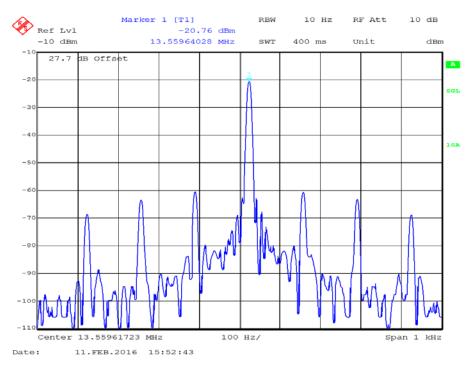


Plot10: 115% voltage; 20°C

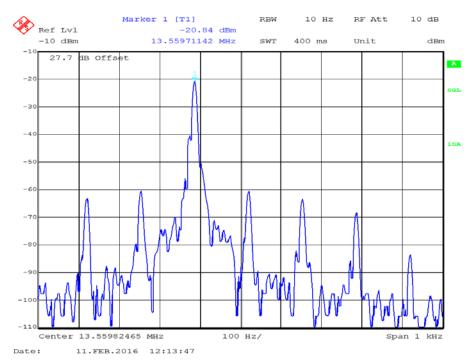




Plot 11: 100% voltage; 20°C



Plot 12: 85% voltage; 20°C





13 Observations

No observations except those reported with the single test cases have been made.

Annex A Document history

Version	Applied changes	Date of release
	Initial release	2016-03-30

Annex B Further information

<u>Glossary</u>

AVG	-	Average
DUT	-	Device under test
EMC	-	Electromagnetic Compatibility
EN	-	European Standard
EUT	-	Equipment under test
ETSI	-	European Telecommunications Standard Institute
FCC	-	Federal Communication Commission
FCC ID	-	Company Identifier at FCC
HW	-	Hardware
IC	-	Industry Canada
Inv. No.	-	Inventory number
N/A	-	Not applicable
PP	-	Positive peak
QP	-	Quasi peak
S/N	-	Serial number
SW	-	Software
PMN		Product marketing name
HMN		Host marketing name
HVIN		Hardware version identification number
FVIN		Firmware version identification number



Annex C **Accreditation Certificate**

Front side of certificate



Deutsche Akkreditierungsstelle GmbH

Bellehene gemäß § 8 Absatz 1 AkkStelleG i.V.m. § 1 Absatz 1 AkkStelleGBV Unterzeichnerin der Multilateralen Abkommen von EA, ILAC und IAF zur gegenseitigen Anerkennung

行家 Akkreditierung

Die Deutsche Akkreditierungsstelle GmbH bestätigt hiermit, dass das Prüflaboratorium CETECOM ICT Services GmbH

Untertürkheimer Straße 6-10, 66117 Saarbrücken

die Kompetenz nach DIN EN ISO/IEC 17025:2005 besitzt, Prüfungen in folgenden Bereichen durchzuführen:

durchzuführen: Drahtgebundene Kommunikation einschließlich xDSL VolP und DECT Akustik Funk einschließlich VULAN Short Range Devices (SRD) RFID WIMax und Richtfunk Mobilfunk (SRM / DCS, Over the Air (OTA) Performance) Elektromagnetische Verträglichkeit (EMV) einschließlich Automotive Produktsicherheit SAR und Hearing Aid Compatibility (HAC) Umweltsimulation Smart Card Terminals Bluetooth Wi-Fi- Services

Die Akkreditierungsurkunde gilt nar in Verbindung mit dem Bescheid vom 07.03.2014 mit der Akkreditierungseummer D-PL-17076-01 und ist giltig 17.01.2018. Sie besteht aus diesem Deckblant, der Rückseite des Deckblants und der fulgenden Anlage mit Ingesamt 77 Seiten.

Registrierungsnummer der Urkunde: D-PL-12076-01-00

Frankfurt am Main, 07.03.2314 Siehe Hanalite auf der Richarde

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Deutsche Akkreditierungsstelle GmbH

Back side of certificate

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Standort Frankfurt am Main Gartenstra3e 6 60594 Frankfurt am Main

Standort Braunschweig Bundesallee 100 38116 Braunschweig

Die suzzugsweise Neröffertlichung der Aktreditierungsurkunde bestanf der verherigen schriftlichen Zuzimmung der Deutsche Akkrediterungszeile Grobel (DAMS). Ausgenemmen davon ist die separate Weisnerventung des Deutschattes durch die umsetig genemme Kanformitikkowerbungszallte in uwerd offerter Form.

Es darf nicht der Anschein erweckt werden, dass sich die Akkred lierung auch auf Bereiche erstreckt, die über den durch die DAkkS bestätigten Akkreditierungsbereich hinausgehen.

Die Akkreditierung erfolgte gemäß des Gesetzes über din Akkreditierungsstelle (Akkstelles) vom 31 Juli 2005 (HGRI, I.S. 2023) woek der Veroritrung (FGI, Nr. 765/2028 des Europäischen Parlamette und des Rites vom S. Juli 2006 (Hdr. die Versichtlicht die die Akkreditierung und Marktüberweiburg im Zuammenhang mit der Vernanklung von Produktion (AbL, 2018 vom S. Juli 2008; S. 30). Die DAkk 51 der Unter- chrenit der Vaulifikation (Abl. 2018 vom S. Juli 2008; S. 30). Die DAkk 51 der Unter- chrenit der Vaulifikation in Akkreditierung auf Marktüberung der Europera en operation für Azereditation (Ed., das Heimatten) Azereditation Form (Ar.) and der intermitiant laberlihrer Azereditation Cooperation (LAC). Die Unteracitier elser Abkommen erkonnen ihre Akkreditierungen gegenzeitig an.

Der aktuelle Stund der Mitgliedschaft kann folgenden Webseiten entnommen werden: FAL: www.couropean.accreditation.org ILAC: www.init.org ILAC: www.init.org